### 3D magnetometer

#### Datasheet



### **Features and Benefits**

- 3-axis magnetometer device suitable for position sensors applications Triaxis<sup>®</sup> (Hall Technology)
- Suitable for space constrained applications (only 2 x 2,5 x 0.4mm)
- Compatible with I<sup>2</sup>C (0.1, 0.4, 1.0 MHz)
- Low power application Power-down mode current of 7nA
- Supply voltage from 1.7V to 3.6V
- Ambient temperature range from -40°C to 105°C
- Digital Output
  - 16-bit Magnetic (XYZ)
  - o 16-bit Temperature
- At runtime selectable modes
  - Magnetic axis selection
  - Single Measurement
  - Continuous Mode up to 1.4kHz (XYZ)
  - Power-Down mode
- RoHS Compliant & Green Package



UTDFN-8

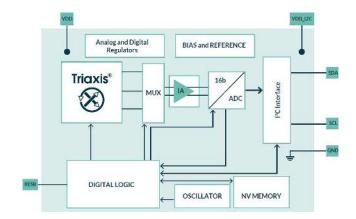
# **Application Examples**

- Battery powered applications
- Power tools Screwdriver trigger
- Home security door/ window opening detection
- Knobs for white goods
- PC peripheral Mouse roller
- Gaming pads
- Joystick with back-bias magnet
- Industrial pneumatic cylinder

## **Description**

The device measures magnetic fields along the 3 axis and is specifically designed for micro-power applications. Those measurements and the IC temperature are transferred upon request over I<sup>2</sup>C communication channel. The device transmits compensated raw measurement data of the selected Bx, By, Bz or a combination.

The MLX90397 is designed for position sensor applications with a ±50mT range and an adaptative range on Bz of ±200mT.



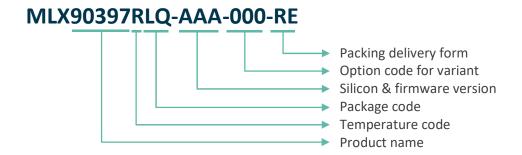


# 1. Ordering Information

| Ordering Code          | Temperature    | Package          | Туре  | Output           | Packing | Definition                      |
|------------------------|----------------|------------------|-------|------------------|---------|---------------------------------|
| MLX90397RLQ-AAA-000-RE | -40°C to 105°C | UTDFN-8<br>2x2.5 | ±50mT | I <sup>2</sup> C | Reel    | I <sup>2</sup> C address = 0x0D |
| MLX90397RLQ-AAA-001-RE | -40°C to 105°C | UTDFN-8<br>2x2.5 | ±50mT | I <sup>2</sup> C | Reel    | I <sup>2</sup> C address = 0x2F |

Table 1: Ordering codes

### Legend:





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# 3. Glossary of Terms

| Term      | Description                                 |
|-----------|---|
| NC        | Not Connected                               |
| ADC       | Analog-to-digital converter                 |
| LSB       | Least significant bit                       |
| MSB       | Most significant bit                        |
| Gauss (G) | Units for magnetic flux density – 1mT = 10G |
| RMS       | Root mean square                            |
| DSP       | Digital signal processing                   |

Table 2: Glossary of terms



# 4. Pins Description and Block diagram

# 4.1. Pins Description

| Pin # | Name (I <sup>2</sup> C) | Description    |
|-------|-------------------------|----------------|
| 1     | SCL                     | [I] Bus clock  |
| 2     | Not used                | Not Connected  |
| 3     | Vss                     | [S] Ground     |
| 4     | SDA                     | [I/O] Bus Data |
| 5     | Not used                | Not connected  |
| 6     | V <sub>DD</sub>         | [S] Supply     |
| 7     | RESB                    | [I] Reset      |
| 8     | $V_{DD\_I2C}$           | [S] I/O supply |

Table 3: Pin description

The exposed pad of the UTDFN-8 package can be left floating or shorted to ground.

# 4.2. Block Diagram

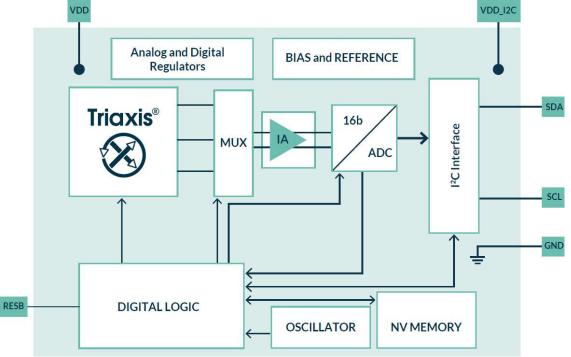


Figure 1: Block diagram



# 5. Conditions and Specifications

# 5.1. Absolute Maximum Ratings (AMR)

Operating characteristics,  $T_A = -40$ °C to 105°C (unless otherwise specified)

| Parameter                               | Symbol                               | Min. | Тур. | Max. | Unit  | Conditions            |
|---|--------------------------------------|------|------|------|-------|-----------------------|
| Supply voltage                          | $V_{DD}$                             |      |      | 4    | V     | <48h                  |
| Reverse supply voltage                  | V <sub>DDREV</sub>                   |      |      | -0.3 | V     | Room temp, <48h       |
| protection                              |                                      |      |      |      |       |                       |
| Supply voltage I <sup>2</sup> C         | $V_{DD\_I2C}$                        |      |      | 4    | V     | <48h                  |
| Reverse I <sup>2</sup> C supply voltage | $V_{DDREV}$                          |      |      | -0.3 | V     | Room temp, <48h       |
| protection                              |                                      |      |      |      |       |                       |
| Output voltage                          | V <sub>SDA</sub>                     |      |      | 4    | V     | <48h                  |
| Reverse output voltage                  | V <sub>SDAREV</sub>                  |      |      | -0.3 | V     | Room temp, <48h       |
| Input voltage                           | V <sub>RESB</sub> , V <sub>SCL</sub> |      |      | 4    | V     | <48h                  |
| Reverse input voltage                   | V <sub>RESBREV</sub> ,               |      |      | -0.3 | V     | typical Vdd operating |
|   | V <sub>SCLREV</sub>                  |      |      |      |       | range,                |
|   |                                      |      |      |      |       | room temp, <48h       |
| Operating temperature                   | TA                                   | -40  |      | +105 | °C    |                       |
| Junction temperature                    | T <sub>JUNC</sub>                    |      |      | +105 | °C    |                       |
| Storage temperature                     | T <sub>storage</sub>                 | -40  |      | 150  | °C    |                       |
| Thermal resistance                      | R <sub>thja</sub>                    |      | 230  |      | °C /W | Junction to ambient   |
|   |                                      |      |      |      |       | 1s0p board            |
|   |                                      |      | 40   |      | °C /W | Junction to ambient   |
|   |                                      |      |      |      |       | multi layered pcb     |
| Thermal resistance                      | R <sub>thjc</sub>                    |      | 3.4  |      | °C /W | Junction to case      |
| Magnetic flux density                   |                                      | -1   |      | 1    | Т     |                       |

Table 4: Absolute Maximum Ratings

Exceeding the absolute maximum ratings may cause permanent damage. Exposure to absolute maximum-rated conditions for extended periods may affect device reliability.



# 5.2. Operating Conditions

# **5.2.1.** General Operating Conditions

| Parameter             | Symbol               | Min. | Тур. | Max. | Unit | Conditions |
|-----------------------|----------------------|------|------|------|------|------------|
| Operating temperature | T <sub>A</sub>       | -40  |      | 105  | °C   |            |
| Storage temperature   | T <sub>storage</sub> | -40  |      | 150  | °C   |            |

Table 5: General operating conditions

## **5.2.2.** Electrical Operating Conditions

| Parameter          | Symbol        | Min. | Тур. | Max. | Unit | Conditions |
|--------------------|---------------|------|------|------|------|------------|
| Supply voltage     | $V_{DD}$      | 1.7  | 1.8  | 3.6  | V    |            |
| I/O supply voltage | $V_{DD\_I2C}$ | 1.7  | 1.8  | 3.6  | V    |            |

Table 6: Electrical operating conditions

## 5.2.3. Magnetic Operating Conditions

| Parameter             | Symbol | Min. | Тур. | Max.              | Unit | Conditions                 |
|-----------------------|--------|------|------|-------------------|------|----------------------------|
| Magnetic flux density | Вху    | -50  |      | 50 <sup>(1)</sup> | mT   | $Bxy = \sqrt{Bx^2 + By^2}$ |
| Magnetic flux density | Bz     | -200 |      | 200 (2)           | mT   | Bz                         |

Table 7: Magnetic operating conditions

<sup>&</sup>lt;sup>1</sup> Above this value, the sensor starts saturating resulting in an increase of the linearity error.

<sup>&</sup>lt;sup>2</sup> For magnetic ranges above 50mT, Melexis only guarantees the performance by design



# **5.3. Electrical Specifications**

Operating characteristics,  $T_A = -40$ °C to 105°C (unless otherwise specified)

| Parameter                         | Symbol                  | Min. | Тур. | Max. | Unit                 | Conditions                                     |
|-----------------------------------|-------------------------|------|------|------|----------------------|--|
| RESB high threshold               |                         | 49   | 61   | 67   | %V <sub>DD</sub>     | ±3sigma  |
| RESB low threshold                |                         | 41   | 50   | 51   | %V <sub>DD</sub>     | ±3sigma  |
| RESB hysteresis                   |                         | 5    | 11   | 17   | %V <sub>DD</sub>     | ±3sigma  |
| DSP current                       | I <sub>DD,DSP</sub>     | 0.7  | 1    | 1.2  | mA                   | V <sub>DD</sub> ≤ 1.8V                         |
|                                   |                         | 1    | 1.5  | 2    | mA                   | V <sub>DD</sub> > 1.8V                         |
| Conversion current                | I <sub>DD</sub> ,CONVXY | 2.4  | 2.9  | 3.5  | mA                   | XY axis, V <sub>DD</sub> ≤ 1.8V                |
|                                   |                         | 2.8  | 3.4  | 4.5  | mA                   | XY axis, V <sub>DD</sub> > 1.8V                |
|                                   | I <sub>DD,CONVZ</sub>   | 3    | 3.8  | 5    | mA                   | Z axis, V <sub>DD</sub> ≤ 1.8V                 |
|                                   |                         | 3.4  | 4.4  | 6    | mA                   | Z axis, V <sub>DD</sub> > 1.8V                 |
| Conversion current                | I <sub>DD,CONVT</sub>   | 0.7  | 0.9  | 1    | mA                   | Temperature, V <sub>DD</sub> ≤ 1.8V            |
|                                   |                         | 1.1  | 1.4  | 1.85 | mA                   | Temperature, V <sub>DD</sub> > 1.8V            |
| Counting state current            | I <sub>DD,CNT</sub>     | 11   | 13   | 15   | μΑ                   | V <sub>DD</sub> ≤ 1.8V                         |
|                                   |                         | 12   | 20   | 25   | μΑ                   | V <sub>DD</sub> > 1.8V                         |
| Power-down current                | I <sub>DD,PD</sub>      |      | 7    | 30   | nA                   | $V_{DD} = 1.8V, T_A = 35^{\circ}C$             |
|                                   |                         |      | 400  | 1000 | nA                   | V <sub>DD</sub> = 1.8V, T <sub>A</sub> = 105°C |
|                                   |                         |      | 25   | 100  | nA                   | $V_{DD} = 3.6V, T_A = 35^{\circ}C$             |
|                                   |                         |      | 600  | 2000 | nA                   | V <sub>DD</sub> = 3.6V, T <sub>A</sub> = 105°C |
| Temperature sensor resolution (3) | T <sub>RES</sub>        | 48   | 50   | 52   | LSB16/°C             |  |
| Temperature sensor accuracy       | T <sub>LIN</sub>        | -3   |      | 3    | °C                   | ±3sigma  |
| Input level high (4)              | V <sub>IH</sub>         | 53   | 65   | 71   | %V <sub>DD_I2C</sub> | SDA, SCL                                       |
| Input level low (4)               | VIL                     | 37   | 49   | 54   | %V <sub>DD_I2C</sub> | SDA, SCL                                       |
| Input level hysteresis (4)        | V <sub>IHYST</sub>      | 9    | 16   | 21   | %V <sub>DD_I2C</sub> | SDA, SCL                                       |
| Input capacitance (4)             | Cin                     |      | 8    | 15   | pF                   | SDA, SCL                                       |
| Output level low                  | Vol                     | 2    | 4    | 6    | mV                   | SDA (Static, 1mA load)                         |
| Output on resistance              | R <sub>dson</sub>       | 2    | 4    | 6    | Ω                    | ±3sigma  |
| Output leakage current            |                         |      | 0.1  | 0.3  | μΑ                   |  |
| ESD HBM                           |                         |      |      | 1    | kV                   | All pins                                       |
| ESD CDM                           |                         |      |      | 0.5  | kV                   | All pins                                       |

 $<sup>^3</sup>$  The data format is 2's complement with 0 LSB16 corresponding to 0°C

<sup>&</sup>lt;sup>4</sup> This specification relates to the sensor and not the I<sup>2</sup>C bus



| Parameter                          | Symbol                   | Min.       | Тур.       | Max.       | Unit     | Conditions  |
|------------------------------------|--------------------------|------------|------------|------------|----------|---|
| Average current  100Hz refresh     | IDD,AVG100-1             |            |            |            |          | Continuous mode TXYZ, OSR_HALL=1 DIG_FILTXY=2 DIG_FILTZ=3 DIG_FILT_TEMP=1 OSR_TEMP=1 Temp Comp enabled Tconv = 2.76ms                     |
|                                    |                          | 0.6<br>0.8 | 0.8        | 1.3        | mA<br>mA | VDD ≤ 1.8V<br>VDD > 1.8V  |
| Average current<br>125Hz refresh   | IDD,AVG125-1             | 170        | 270        | 340        | μΑ       | Continuous mode XZ or YZ measured only, OSR_HALL=1 DIG_FILTXY=0 DIG_FILTZ=1 Temp Comp disabled Tconv = 707µs  VDD ≤ 1.8V                  |
|                                    |                          | 200        | 320        | 430        | μΑ       | VDD > 1.8V  |
| Average current<br>125Hz refresh   | IDD,AVG125-1             |            |            |            |          | Continuous mode TXZ or TYZ measured only, OSR_HALL=1 DIG_FILTXY=0 DIG_FILTZ=1 DIG_FILT_TEMP=1 OSR_TEMP=1 Temp Comp enabled Tconv = 1.18ms |
|                                    |                          | 220<br>270 | 320<br>400 | 390<br>530 | μA<br>μA | VDD ≤ 1.8V<br>VDD > 1.8V  |
| Average current<br>125Hz refresh   | I <sub>DD,AVG125-1</sub> |            |            |            |          | Continuous mode XY measured only, OSR_HALL=1 DIG_FILTXY=0 Temp Comp disabled Tconv = 600µs  |
| Table 9: Flortrical Specifications |                          | 160<br>190 | 200<br>250 | 250<br>330 | μΑ<br>μΑ | VDD ≤ 1.8V<br>VDD > 1.8V  |

Table 8: Electrical Specifications



### 5.3.1.1. Average consumption

Figure 2: Average Consumption vs Filtering - Continuous measurement mode - Temperature compensation on

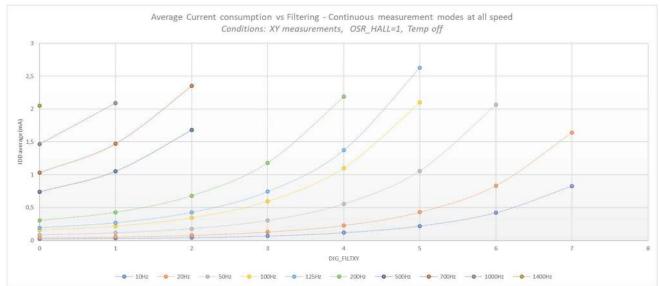


Figure 3: Average Consumption vs Filtering – Continuous measurement at all possible speeds – Temp compensation off



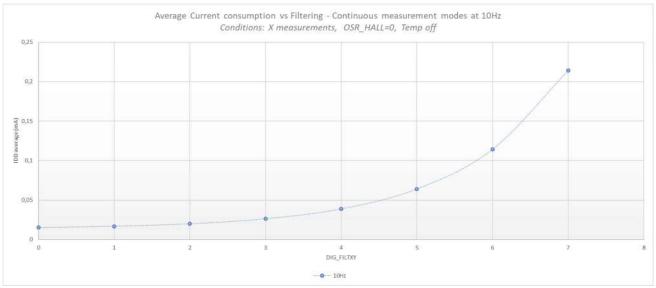


Figure 4: Average consumption vs Filtering – Continuous measurements at 10Hz – Temperature compensation off

#### Average current consumption calculation

 $T_{DSP} = f(T_COMP_EN, Number_Enabled_Magnetic_Axes)$ 

$$T_{refresh} = \frac{1}{F_{refresh}}$$

 $T_{CNT} = T_{refresh} - \left(T_{COMP} - EN \cdot T_{CONV} - T + X_{EN} \cdot T_{CONV} - XY + Y_{EN} \cdot T_{CONV} - XY + Z_{EN} \cdot T_{CONV} - ZY + T_{DSP}\right)$ 

 $I_{\mbox{\scriptsize DD\_AVG}} = \frac{T_{\mbox{\scriptsize COMP\_EN-T}\mbox{\scriptsize CONV\_T}} \cdot I_{\mbox{\scriptsize DD\_CONV\_T}} + X_{\mbox{\scriptsize EN-T}\mbox{\scriptsize CONV\_XY}} \cdot I_{\mbox{\scriptsize DD\_CONV\_XY}} + Y_{\mbox{\scriptsize EN-T}\mbox{\scriptsize CONV\_XY}} \cdot I_{\mbox{\scriptsize DD\_CONV\_XY}} + Z_{\mbox{\scriptsize EN-T}\mbox{\scriptsize CONV\_Z}} \cdot I_{\mbox{\scriptsize DD\_CONV\_Z}} \cdot I_{\mbox{\scriptsize DD\_DSP}} + T_{\mbox{\scriptsize CNT}} \cdot I_{\mbox{\scriptsize DD\_CNT}} - T_{\mbox{\scriptsize CNT}\mbox{\scriptsize CNT}} - T_{\mbox{\scriptsize CNT}\mbox{\scriptsize CNT}\mbox{\scriptsize CNT}} - T_{\mbox{\scriptsize CNT}\mbox{\scriptsize CNT}\mbo$ 



# 5.4. Magnetic Specifications

Operating characteristics,  $T_A = -40$ °C to 105°C (unless otherwise specified)

| Parameter                      | Symbol   | Min.                                      | Тур.                                      | Max.                                       | Unit   | Conditions  |
|--------------------------------|--|---|---|--|--|---|
| XY Magnetic sensitivity        | SENS <sub>XY_25</sub><br>SENS <sub>XY_50</sub>   | 0.675<br>1.35                             | 0.75<br>1.5                               | 0.825<br>1.65                              | μT/LSB16<br>μT/LSB16                         | room temperature,<br>25mT range<br>50mT range   |
| Z Magnetic sensitivity         | SENS <sub>Z_25</sub><br>SENS <sub>Z_50</sub><br>SENS <sub>Z_100</sub><br>SENS <sub>Z_200</sub> | 0.675<br>1.35<br>2.7<br>5.4               | 0.75<br>1.5<br>3                          | 0.825<br>1.65<br>3.3<br>6.6                | μT/LSB16<br>μT/LSB16<br>μT/LSB16<br>μT/LSB16 | room temperature,<br>25mT range<br>50mT range<br>100mT range<br>200mT range   |
| Magnetic measurement range XY  | Brange_xy_25<br>Brange_xy_50   | ±22,107<br>±44,215                        | ±24,564<br>±49,128                        | ±27,020<br>±54,041                         | μT<br>μT                                     | room temperature,<br>25mT range<br>50mT range   |
| Magnetic measurement range Z   | Brange_z_25 Brange_z_50 Brange_z_100 Brange_z_200  | ±22,107<br>±44,215<br>±88,430<br>±176,860 | ±24,564<br>±49,128<br>±98,256<br>±196,512 | ±27,020<br>±54,041<br>±108,082<br>±216,163 | μΤ<br>μΤ<br>μΤ<br>μΤ                         | room temperature,<br>25mT range<br>50mT range<br>100mT range<br>200mT range   |
| RMS noise <sup>(5)</sup>       | Nxyz   |   | 1.90<br>2.40                              | 2.20<br>2.80                               | μTrms<br>μTrms                               | without temperature compensation 5ms conv time DIG_FILTXY=3 DIG_FILTZ=4, OSR_HALL=1, room temperature 25mT range 50mT range |
| RMS Noise <sup>(5)</sup>       | N <sub>XYZ</sub>   |   | 2.00<br>2.90                              | 2.30<br>3.50                               | μTrms<br>μTrms                               | with temperature compensation 5ms conv time (DIG_FILTXY=3 DIG_FILTZ=4, OSR_HALL=1), room temperature 25mT range 50mT range  |
| Sensitivity drift vs TA = 35°C | SENS <sub>THD</sub>  | -5<br>-8                                  |   | 5  | %  | With temperature compensation  Without temperature compensation   |
| Hysteresis                     | B <sub>h</sub>   | 200                                       |   |  | μТ   |   |

Table 9: Magnetic Specifications

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<sup>&</sup>lt;sup>5</sup> Not validated by any production test, only verified by characterization



# 5.5. Timing Specifications

Operating characteristics, T<sub>A</sub> = -40°C to 105°C (unless otherwise specified)

| Parameter                                     | Symbol           | Min.    | Тур.    | Max.    | Unit | Conditions   |
|---|------------------|---------|---------|---------|------|--|
| Output refresh rate (6)                       | Fr1              | 10      | 100     | 700     | Hz   | With temperature measurement (7)                     |
| Output refresh rate ***                       | Fr2              |         |         | 1400    | Hz   | Without<br>temperature<br>measurement <sup>(6)</sup> |
| Oscillator trimming accuracy                  | TOSC_TRIM        | -5      | 0       | 5       | %    | room temperature                                     |
| Oscillator thermal drift                      | TOSC_THD         | -5      | 0       | 5       | %    |  |
| Magnetic avis/Town ereture                    | Tconv            | 105.8   | 113.3   | 121.9   | μs   | Time per axis DIG_FILT=0, OSR=0                      |
| Magnetic axis/Temperature conversion time (8) | Tconv            | 205.5   | 220.0   | 236.7   | μs   | Time per axis DIG_FILT=0, OSR=1                      |
|   | Tconv            | 902.8   | 966.7   | 1040.2  | μs   | Time per axis DIG_FILT=3, OSR=1                      |
|   | Tconv            | 12857.5 | 13766.7 | 14814.2 | μs   | Time per axis DIG_FILT=7, OSR=1                      |
| Start-up time                                 | TStartup         |         | 0.15    | 1.2     | ms   | Reset to power-<br>down mode                         |
| Manual reset                                  | T <sub>RES</sub> | 3       | 5       |         | μs   | Minimum time to<br>trigger a reset<br>Vdd>1.7V       |
| DSP Time                                      | T <sub>DSP</sub> | 359.9   | 385.4   | 414.7   | μs   | TXYZ enabled (6)                                     |
|   |                  | 223.0   | 238.8   | 256.9   | μs   | XYZ enabled <sup>(6)</sup>                           |

Table 10: Timing specifications

6

<sup>&</sup>lt;sup>6</sup> Fr1 and Fr2 are defined as the period between two set of measurements. It is relevant for the Continuous measurement mode and is defined by the parameter MODE[3:0]. TREFRESH is adjustable with the following settings: 10Hz, 20Hz, 50Hz, 100Hz, 125Hz, 200Hz, 500Hz, 700Hz, 1000Hz, and 1.4kHz. The default value in the non-volatile memory is 100Hz.

 $<sup>^{7}\,\</sup>mbox{The temperature compensation can be enabled or disabled by the user.}$ 

<sup>&</sup>lt;sup>8</sup> This conversion time is defined as the time to acquire a single axis of the magnetic flux density. When measuring XYZ, they are obtained through time-multiplexing. The conversion time is programmable through DIG\_FILT for magnetic and temperature conversion. The total conversion time is obtained by summing up the magnetic & temperature conversion time.



### 5.5.1.1. Magnetic Axis/Temperature Conversion time

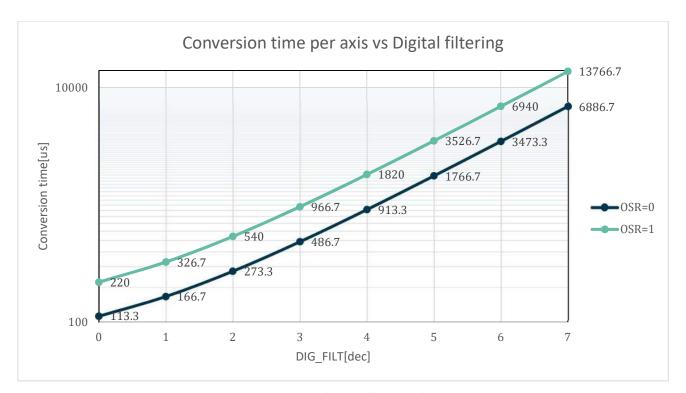


Figure 5: Conversion time vs. digital filtering (DIG\_FILT) at typical Fclk = 2.4MHz

The above graph can be expressed with the following formula ( $F_{clk} = 2.4MHz$  typically):

$$T_{CONV}(OSR,DIG\_FILT) = \frac{16 + 2^{(OSR+5)} \cdot \left(2^{(DIG\_FILT+2)} + 4\right)}{F_{clk}}$$



#### 5.5.1.2. **DSP Time**

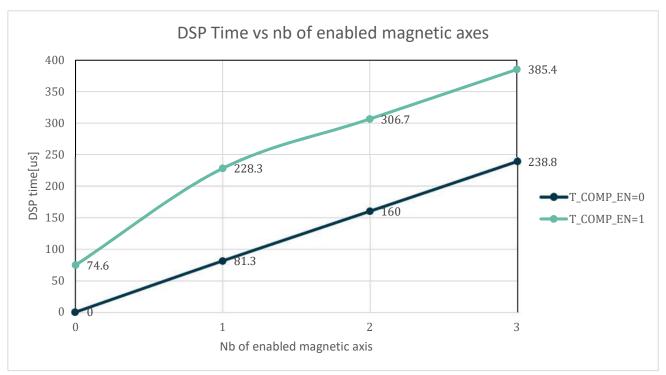


Figure 6: DSP time vs. number of enabled magnetic axes at typical Fclk = 2.4MHz.

### 5.5.1.3. Reset sequence

The MLX90397 does not embark a Power on Reset. The reset should be performed by the user using the RESB external pin. Melexis recommends to follow the below timings:

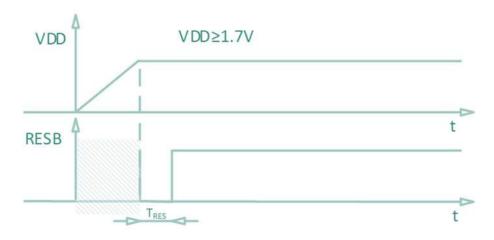


Figure 3: Reset sequence



# 5.6. Accuracy Specifications

Operating characteristics,  $T_A = -40$ °C to 105°C (unless otherwise specified). All specifications in this chapter are given with  $\pm 3$  sigma.

| Parameter   | Symbol                                       | Min.                                     | Тур.                                      | Max.                                 | Unit                     | Conditions  |
|---|--|--|---|--------------------------------------|--------------------------|---|
| Resolution <sup>(9)</sup>   |  |  | 16  |                                      | bits                     | XYZ   |
| Offset (10)   | OFFSX<br>OFFSY<br>OFFSZ                      | -200<br>-200<br>-200                     |   | 200<br>200<br>200                    | μТ                       | at 0 Gauss,<br>Room temperature,<br>Ranges 25mT and<br>50mT   |
| Offset thermal drift X-axis Offset thermal drift Y-axis Offset thermal drift Z-axis |  | -100<br>-100<br>-100                     |   | 100<br>100<br>100                    | μТ                       | vs. T <sub>A</sub> = 35°C   |
| Sensitivity mismatch  | SMISMXY<br>SMISMXZ<br>SMISMYZ                | -1.5<br>-3<br>-5.1                       | 2.1<br>1.7<br>-0.8                        | 5.7<br>6.4<br>3.5                    | %<br>%<br>%              |   |
| Thermal drift of sensitivity mismatch   |  | -200                                     |   | 200                                  | ppm/°C                   |   |
| Cross-axis sensitivity (11)   | Sxyi<br>Syxi<br>Sxzi<br>Szxi<br>Syzi<br>Szyi | -5<br>-3.9<br>-5.1<br>-2.4<br>-4<br>-3.8 | -0.3<br>0.6<br>-2.1<br>-0.2<br>0.9<br>0.7 | 4.4<br>5.1<br>0.9<br>2<br>5.8<br>5.2 | %<br>%<br>%<br>%<br>%    | verified by characterization / not by final testing   |
| Non-linearity   |  | -0.3<br>-0.1<br>-0.4<br>-0.2             |   | 0.3<br>0.1<br>0.4<br>0.2             | %FS<br>%FS<br>%FS<br>%FS | DIG_FILT = 7. Best fit<br>method<br>Verified by<br>characterization only.<br>XY, range 25mT<br>Z, range 25mT<br>XY, range 50mT<br>Z, range 50mT |

Table 11: Accuracy specifications

<sup>&</sup>lt;sup>9</sup> The data format is 2's complement, further explanation can be found on *Table 14: Magnetic data format* 

 $<sup>^{10}</sup>$  Value of measurement data register on shipment test without applying magnetic field on purpose. These values are guaranteed in the operating magnetic field range.

<sup>&</sup>lt;sup>11</sup> The cross axis sensitivity is measured by applying a force field on one axis and measured on another axis. For instance, S<sub>XYi</sub> means that a field was applied along X axis and measured along Y axis.



# **6.** Functional Description & Interfaces

# 6.1. Operating Modes

MLX90397 has the following Application modes

- 1. Power-down mode
- 2. Single measurement mode
- 3. Continuous measurement mode (10Hz, 20Hz, 50Hz, 100Hz, 125Hz, 200Hz, 500Hz, 700Hz, 1000Hz, and 1.4kHz)

| Operating Mode        | Start of Mode   | End of Mode (Return<br>to power-down) | Measurement Data |
|-----------------------|---|---------------------------------------|------------------|
| Single<br>measurement | Command to enter mode 1 or 9                            | Measurement finished                  | (T)XYZ           |
| Continuous<br>mode    | Command to enter mode 2, 3, 4, 5, 6, 10, 11, 12, 13, 14 | Transition to other mode              | (T)XYZ           |
| Power-down<br>Mode    | Power up or command to enter mode 0, 8, 15              | Transition to other mode              | -                |

Table 12: Operating modes

Note: To change an operating mode, the sensor should be first in power-down mode.



### 6.1.1. Single Measurement Mode

When the *Single measurement mode* is set, a magnetic measurement is started. After a measurement and when the signal processing is finished, the measurement data is stored to the data registers (**X**, **Y** and **Z**). After this, the sensor will go to the *power-down mode* automatically.

While going to the *power-down mode*, **MODE[3:0]** bits turn to 0. At the same time, **DRDY** bit (Data Ready) in **STAT1** register turns to High.

When any of measurement data register (**X**, **Y** and **Z**) is read, **DRDY** bit turns to Low. It remains High when switching from *power-down mode* to another mode.

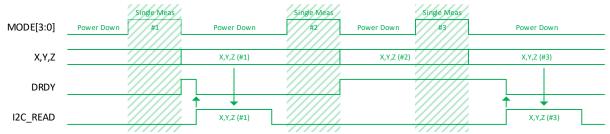


Figure 7: Single measurement mode when data is read out of measurement period

When the sensor is measuring, the data registers (**X**, **Y** and **Z**) keep the previous data. Therefore, it is possible to read out data even during measurement periods.

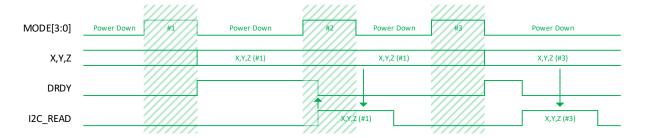


Figure 8: Single measurement mode when data read started during measurement period

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#### 6.1.2. Continuous Measurement Mode

When the "Continuous measurement" mode is set, the measurement starts periodically. After measurement and signal processing is finished, the measurement data is stored to the data registers (X, Y, and Z). Almost all internal blocks are disabled ("Counting" power state).

After a measurement period, **the device** wakes up automatically from "*Counting*" power state and starts a new measurement.

The Continuous measurement mode ends when "power-down" mode (MODE[3:0] bits = 0) is set. If the measurement period is changed while <u>the device</u> is already configured in "Continuous measurement" mode, a new measurement starts.

**STAT1** and measurement data registers (**X**, **Y** and **Z**) will not be initialized by this.



Figure 9: Continuous measurement mode

#### 6.1.2.1. Data Ready

When the measurement data is stored and ready to be read, the **DRDY** bit (Data ready) in STAT register is set to High. When a measurement is performed correctly, the device sets the Data Ready bit before going back to "Counting" power state.

#### 6.1.2.2. Normal Read Sequence

The stored measurement data is protected during the data reading. There is no update of the data during this time. Consequently, the following sequence should be followed:

- 1. Check if the Data is Ready or not by polling DRDY bit of STAT1 register
  - a. **DRDY**: Data Ready. The Data is ready when set High.
- 2. Reading of the STAT1 register will not trigger the protection.
- 3. **Read measurement data** When **any of** the measurement data register (X, Y, or Z) is read, the device enables the protection as soon as the register is copied into the I<sup>2</sup>C sending register. When data reading starts, **DRDY (Data ready)** bit turns Low.
- 4. Read STAT2 register (required for data consistency provides information on overflow and data skip)

When this read sequence is followed and there is no attempted I<sup>2</sup>C read during measurement, reading of STAT2 sets the DOR bit to low (see I/O registers description for reference).



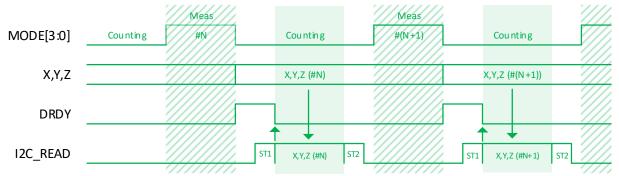


Figure 10: Normal read sequence

### 6.1.2.3. Data Read Start During Measurement

When the sensor is measuring, the measurement data registers (**X**, **Y** and **Z**) keep the previous data. Therefore, it is possible to read out data even in measurement period.

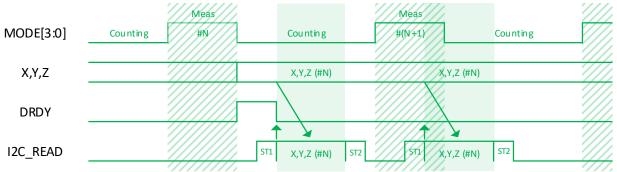


Figure 11: Data read start during measurement



#### 6.1.2.4. Timing Considerations

The device offers many options for different axis configurations depending on the tradeoff between:

- noise-measurement time
- current consumption
- temperature compensation
- axis selection

Whichever settings are chosen depending on the application specific requirements, the following timing consideration should be always considered during design in order to ensure proper continuous measurement mode operation:

$$T_{CONV\_TEMP} + T_{CONV\_X} + T_{CONV\_Y} + T_{CONV\_Z} + T_{DSP} + 66\mu s < 1/Fr$$

#### Example 1:

The lowest possible noise and temperature compensation of XYZ magnetic sensitivities at refresh rate of 100Hz ( $10,000 \mu s$  period) result in the following settings:

- OSR\_HALL = OSR\_TEMP = 1b, DIG\_FILT\_XY = 6d, DIG\_FILT\_TEMP = 1d
- Temperature compensation enabled, DIG FILT Z = 7d
- X, Y, Z enabled, MODE[3:0] = 5h (100Hz)

Referring to the timing specifications and the inequality, for the selected settings follows:

326.7μs + 6,940.0μs + 6,940.0μs + 13,766.7μs + 385.4μs + 66μs < 10,000μs  $\rightarrow$  The criterion is not satisfied because the selected refresh rate is not slow enough.

#### Example 2:

The lowest possible noise and temperature compensation of XYZ magnetic sensitivities at refresh rate of 20Hz (50,000 µs period) result in the following settings:

- OSR\_HALL = OSR\_TEMP = 1b, DIG\_FILT\_XY = 6d, DIG\_FILT\_TEMP = 1d
- Temperature compensation enabled, DIG\_FILT\_Z = 7d
- X, Y, Z enabled, MODE[3:0] = 3h (20Hz)

Referring to the timing specifications and the inequality for the selected settings follows:  $326.7\mu s + 6940.0\mu s + 6940.0\mu s + 13766.7\mu s + 385.4\mu s + 66\mu s < 50,000\mu s \rightarrow The criterion is satisfied.$ 

| Refresh rate                  | 10Hz | 20Hz | 50Hz | 100Hz | 125Hz | 200Hz | 500Hz | 700Hz | 1KHz | 1.4KHz |
|-------------------------------|------|------|------|-------|-------|-------|-------|-------|------|--------|
| Measurements                  | TXYZ | TXYZ | TXYZ | TXYZ  | TXYZ  | TXYZ  | TXYZ  | TXYZ  | XY   | XY     |
| T_COMP_EN<br>(binary)         | 1    | 1    | 1    | 1     | 1     | 1     | 1     | 0     | 0    | 0      |
| OSR_HALL (binary)             | 1    | 1    | 1    | 1     | 1     | 1     | 1     | 1     | 1    | 0      |
| OSR_TEMP<br>(binary)          | 1    | 1    | 1    | 1     | 1     | 1     | 1     | N/A   | N/A  | N/A    |
| DIG_FILT_TEMP<br>(decimal)    | 6    | 1    | 1    | 1     | 1     | 1     | 1     | N/A   | N/A  | N/A    |
| DIG_FILT_HALL_XY (decimal)    | 6    | 6    | 5    | 4     | 3     | 2     | 0     | 0     | 0    | 1      |
| DIG_FILT_HALL_Z,<br>(decimal) | 7    | 7    | 6    | 5     | 4     | 3     | 1     | 1     | N/A  | N/A    |

Table 13: Example of settings satisfying the timing consideration for proper operation in continuous measurement mode



### 6.1.2.5. Data Skip

If the available data is not read before a new measurement ends, the DRDY bit (Data Ready) remains High. However, a new set of measurement data will replace the previous one.

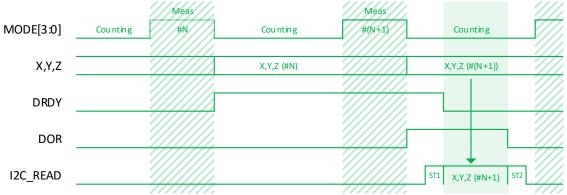


Figure 12: Data Skip: When data is not read

If the available data is read while a new measurement is being performed, this set of data will be protected. This is also the case even if the reading procedure finishes after the measurement. Consequently, this new set of data is skipped.

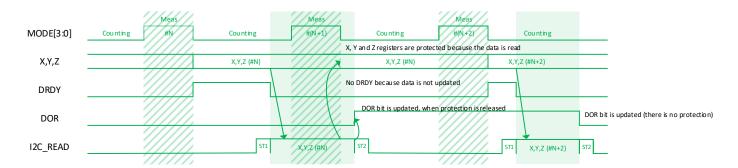


Figure 13: Data Skip: When data read has not been finished before the next measurement end

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#### 6.1.2.6. End Operation

Set the power-down mode (MODE[3:0] bits = 0) to end the Continuous measurement mode.

#### 6.1.2.7. Magnetic Sensor Overflow

The device has two separate limitations for measurement range. Combined for X and Y axes and another one for Z axis. The absolute values of X and Y axis should be smaller than 25mT or 50mT depending on the selected range.

Along Z axis, the absolute value should be smaller than 25mT, 50mT, 100mT or 200mT depending on the selected range.

| X, Y, Z<br>(2's complement) | X, Y, Z<br>(HEX) | X, Y, Z<br>(Decimal) | Range =<br>25mT<br>[μΤ] | Range =<br>50mT<br>[μΤ] | Range =<br>100mT<br>[μΤ] | Range =<br>200mT<br>[μΤ] |
|-----------------------------|------------------|----------------------|-------------------------|-------------------------|--------------------------|--------------------------|
| 0111 1111 1111 0000         | 7FF0             | 32,752               | 24,564                  | 49,128                  | 98,256                   | 196,512                  |
|                             |                  |                      |                         |                         |                          |                          |
| 0000 0000 0000 0001         | 0001             | 1                    | 0.75                    | 1.50                    | 3.00                     | 6.00                     |
| 0000 0000 0000 0000         | 0000             | 0                    | 0                       | 0                       | 0                        | 0                        |
| 1111 1111 1111 1111         | FFFF             | -1                   | -0.75                   | -1.50                   | -3.00                    | -6.00                    |
| I                           |                  | I                    |                         |                         |                          |                          |
| 1000 0000 0001 0000         | 8010             | -32,752              | -24,564                 | -49,128                 | -98,256                  | -196,512                 |

Table 14: Magnetic data format

When the magnetic field exceeds the limitation, data stored at measurement data are not correct. This is called Magnetic Sensor Overflow.

For X axis overflow flag condition is: |X| > 32,752

When the condition is performed, HOFL\_X bit turns to "1".

For Y axis overflow flag condition is: |Y| > 32,752

When the condition is performed, HOFL\_Y bit turns to "1".

For Z axis overflow check is: |Z| > 32,752 If the condition is fulfilled, the HOFL Z bit turns to "1".

When measurement data register (X, Y and Z) is updated, HOFL\_X, HOFL\_Y and HOFL\_Z bits are updated, too

#### 6.1.3. Power-Down Mode

In power-down mode, the device is in minimal power consumption state. All internal blocks are disabled. Only the communication over the I<sup>2</sup>C interface is maintained. The digital handling of the communication is clocked by the I<sup>2</sup>C master clock. All registers remain accessible and the data stored in read/write registers remains.



## 6.2. Measurement Axis Selection

Each measurement axis (i.e X, Y or Z) can be selected and then measured individually or through a combination of 2 or 3 axis.

This is user configurable through the CTRL register. See chapter 6.5.2.7 for more details.

## 6.3. Magnetic Range Selection

The magnetic range is controlled through the RANGE\_SEL parameter.

| RANGE_SEL[2:0]    | X & Y ranges [mT] | Z range [mT] |
|-------------------|-------------------|--------------|
| 0                 | 25                | 25           |
| 1                 | 50                | 25           |
| 2                 | 25                | 50           |
| 3 (default)       | 50                | 50           |
| 4 <sup>(12)</sup> | 25                | 100          |
| 5 <sup>(12)</sup> | 50                | 100          |
| 6 <sup>(12)</sup> | 25                | 200          |
| 7 <sup>(12)</sup> | 50                | 200          |

Table 15: XY and Z magnetic range selection

## 6.4. Output Protocol (I<sup>2</sup>C) Description

The 7-bit I<sup>2</sup>C address is pre-programmed to a fixed value of 0x0D. This value cannot be changed by the user. Please contact Melexis in case a specific address is needed.

| Description | 7-bits I <sup>2</sup> C address | R/W bit   |
|-------------|---------------------------------|---|
| bits        | 7-1                             | 0   |
| value       | 0x0D or 0b0001101               | 0 for I <sup>2</sup> C write<br>1 for I <sup>2</sup> C read |

Table 16: 8-bits Addressing register

-

<sup>&</sup>lt;sup>12</sup> For magnetic ranges above 50mT, Melexis only guarantees the performance by design



### **6.4.1.** Command implementation

The following I<sup>2</sup>C commands are implemented:

- MEM\_DIRECT\_READ: reads data from memory space, starting from the default address 0x00
- **MEM\_READ**: the start address will be specified in the command and the address will be incremented for continuous reading until an I<sup>2</sup>C stop is detected.
- **MEM\_WRITE**: the start address will be specified followed by the data to be stored at addresses starting from the given start address and incremented until an I<sup>2</sup>C stop is detected.
- ADDRESSED\_RESET: reset of the device, based on the I<sup>2</sup>C Slave Address (reset of addressed devices on the I<sup>2</sup>C bus only)

In the next sections, the format of the different I<sup>2</sup>C commands is explained. The following legend is used:





#### 6.4.1.1. Read Commands

There are two read commands that are implemented

- MEM\_DIRECT\_READ: reads data from memory space, starting from the default address 0x00
- MEM\_READ: the start address will be specified in the command and the address will be incremented for continuous reading until an I<sup>2</sup>C stop is detected.

#### 6.4.1.1.1. MEM\_DIRECT\_READ (direct read) Command

MEM\_DIRECT\_READ: reads data from memory space, starting from the default address 0x00



Figure 14: I<sup>2</sup>C - MEM\_DIRECT\_READ (direct read) Command

#### **NOTES:**

- Incremental readout return 0x00 when address out of valid space
- NAK is needed from master to allow going to STOP

#### 6.4.1.1.2. MEM READ (addressed read)

**MEM\_READ:** the start address will be specified in the command and the address will be incremented for continuous reading until an I<sup>2</sup>C stop (P) is detected.

Incremental read-out starting at a given address (Register Start Address).

Normally it will read 1x register only, but the slave will continue to transmit data of sequential register addresses until the master terminates the communication.



Figure 15: I<sup>2</sup>C - MEM\_READ (addressed read)

Important! A repeated START is required to perform an "addressed read". Without repeated START, the command will be seen as a "direct read".

As soon as incremental addressing leaves the address space, the slave will respond with all 0x00. NOTES:

- Incremental readout return 0x00 when address out of valid space
- NAK is needed from master to allow going to STOP

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#### 6.4.1.2. MEM\_WRITE (addressed write) Command

**MEM\_WRITE:** the start address will be specified followed by the data to be stored at addresses starting from the given start address and incremented until an I<sup>2</sup>C stop (P) is detected.

Incremental write starting at a given address (Register Start Address).

Normally you write 1x register only, but optionally the master can continue to transmit data of sequential register addresses to reduce the communication time when a lot of registers should be written.



Figure 16: I<sup>2</sup>C - MEM WRITE (addressed write) Command

The slave is sending AK/NAK based on the fact whether it was able to write data

The slave will automatically increment the address of the read out byte, independent if it gave an AK or a NAK to the master. It is up to the master to re-write the byte afterwards.

When the device is busy with the write operation, new write commands will be ignored. A read operation will return invalid data.

#### 6.4.1.3. ADDRESSED\_RESET: Addressed reset



The addressed reset command brings the device back into a state like it was after power-on.

The I<sup>2</sup>C Slave Address is used, which means that only the addressed devices on the I<sup>2</sup>C bus will be reset.



# 6.5. Memory Items Description

## 6.5.1. Memory Structure

The MLX90397 has registers (ports) of 16 addresses. Each address consists of 8 bits data. Data is transferred to or received from the external CPU via the I<sup>2</sup>C interface.

| Address | Name            | Description                                | R/W | 7        | 6        | 5         | 4         | 3     | 2                  | 1           | 0      |
|---------|-----------------|--|-----|----------|----------|-----------|-----------|-------|--------------------|-------------|--------|
| 0x00    | STAT1           | Status Register 1                          | R   | -        | - 5      | -         | -         | RT    | -                  | -           | DRDY   |
| 0x01    | X[7:0]          | X-axis Measurement Magnetic Data [7:0]     | R   | -        |          | -         | -         | -     | 8                  | -           | -      |
| 0x02    | X[15:8]         | X-axis Measurement Magnetic Data [15:8]    | R   |          |          | -         | 12        | 12    | 2                  | -           | - 2    |
| 0x03    | Y[7:0]          | Y-axis Measurement Magnetic Data [7:0]     | R   |          | -        | -         | - 3       | -     | -                  | -           |        |
| 0x04    | Y[15:8]         | Y-axis Measurement Magnetic Data [15:8]    | R   | 3.6      | -        | -         | - 4       | -     | 8                  | (*)         | -      |
| 0x05    | Z[7:0]          | Z-axis Measurement Magnetic Data [7:0]     | R   |          | -        | 2         | - 4       |       | -                  |             | 10-1   |
| 0x06    | Z[15:8]         | Z-axis Measurement Magnetic Data [15:8]    | R   | 7        | -        |           | 1.5       |       | -                  | 1-          | -      |
| 0x07    | STAT2           | Status Register 2                          | R   | 196      | -        | 9         |           | DOR   | HOVF_Z             | HOVF_Y      | HOVF_X |
| 0x08    | T[7:0]          | Temperature Measurement Data Lower 8-bit   | R   | -        | 12       | 9         |           | -     | 25                 | -           | -      |
| 0x09    | T[15:8]         | Temperature Measurement Data Higher 8-bit  | R   |          | -        | -         | - 15      |       | -                  | 17          | -      |
| 0x0A    | CID             | Company ID [7:0]                           | R   |          | -        | -         | -         | -     | -                  | -           | -      |
| 0x0B    | DID             | Device ID [7:0]                            | R   | 16       | =        | -         |           |       | 9                  | -           | = =    |
| 0x0C    |                 | Not used                                   |     | (6)      |          | =         |           |       | =                  | 1,75        | UES    |
| 0x0D    |                 | Not used                                   |     | (+)      | -        | -         |           | - 1   | -                  | 1-0         | 16     |
| 0x0E    | CTRL            | Control Register (Application Mode)        | R/W | 160      | Z_EN     | Y_EN      | X_EN      |       | MOD                | E[3:0]      |        |
| 0x0F    | CUST_CTRL2      | Second Control Register (Application Mode) | R/W | Ubi      |          | -         |           | 18    | RA                 | NGE_SEL[2:  | 0]     |
| 0x10    |                 | Not used                                   |     | (2)      | *        | -         |           | -     | -                  | -           | 160    |
| 0x11    | RST             | Reset = 0x06                               | R/W | -        | -        | -         |           |       | -                  | -           |        |
| 0x12    |                 | Not used                                   |     | (6)      | -        |           |           |       | -                  | S=-         | 161    |
| 0x13    |                 | Not used                                   |     | -        | -        | 2         |           | -     | 25                 | -           | 1,21   |
| 0x14    | OSR_DIG_FILT    | OSR_DIG_FILT[7:0]                          | R/W | OSR_HALL | OSR_TEMP | DIG_FIL   | T_HALL_XY | [2:0] | DIG_FILT_TEMP[2:0] |             |        |
| 0x15    | T_EN_DIG_FILT_Z | CUST_CTR                                   | R/W | DNC=1    | DNC=0    | T_COMP_EN | DNC=1     | -     | DIG_I              | FILT_HALL_Z | [2:0]  |

Table 17: Memory map

### **DNC**=Do Not Change

The **STAT1** register is mapped on address **0x00**, since it is the default address of **MEM\_DIRECT\_READ** (direct read) command.

The idea is that first the user has to read the status bits **DRDY** to check if there is new data and if there is new data, to continue the command to read the registers **X**, **Y** and **Z**.



# 6.5.2. I/O Registers Description

## 6.5.2.1. Address 0x00. STAT1[7:0]

| 7       | 6       | 5       | 4       | 3    | 2       | 1       | 0    |
|---------|---------|---------|---------|------|---------|---------|------|
| STAT1_7 | STAT1_6 | STAT1_5 | STAT1_4 | RT   | STAT1_2 | STAT1_1 | DRDY |
| RW-0    | RW-0    | RW-0    | RW-0    | RW-1 | RW-0    | RW-0    | RW-0 |

NOTE: R=Read access; W=Write access; value following dash (-) = value after reset

| Bit 7-4 | STAT1[7:4] Reserved (Not used)  |  |  |  |  |  |  |
|---------|---|--|--|--|--|--|--|
| Bit 3   | RT The device is reset  |  |  |  |  |  |  |
|         | 0 – The device was not reset  |  |  |  |  |  |  |
|         | 1 – The device was reset and this is the first reading. Automatically set to 0 when the |  |  |  |  |  |  |
|         | first reading of STAT register is done.   |  |  |  |  |  |  |
| Bit 2-1 | STAT1[2:1] Reserved (Not used)  |  |  |  |  |  |  |
| Bit 0   | DRDY Data ready   |  |  |  |  |  |  |
|         | DRDY bit turns to "1" when data is ready in "Single measurement" mode, or "Continuous   |  |  |  |  |  |  |
|         | measurement" mode. It returns to "0" when any one the measurement register (X, Y, or Z) |  |  |  |  |  |  |
|         | is read   |  |  |  |  |  |  |
|         | 0 – Normal  |  |  |  |  |  |  |
|         | 1 – Data is ReaDY   |  |  |  |  |  |  |

## 6.5.2.2. Addresses 0x00-0x06. XYZ[15:0]

| 0x01 | X[7:0] LSByte of X-axis  |
|------|--------------------------|
| 0x02 | X[15:8] MSByte of X-axis |
| 0x03 | Y[7:0] LSByte of Y-axis  |
| 0x04 | Y[15:8] MSByte of Y-axis |
| 0x05 | Y[7:0] MSByte of Z-axis  |
| 0x06 | Y[15:8] MSByte of Z-axis |

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### 6.5.2.3. Address 0x07. STAT2[7:0]

| 7       | 6       | 5       | 4       | 3    | 2      | 1      | 0      |
|---------|---------|---------|---------|------|--------|--------|--------|
| STAT2_7 | STAT2_6 | STAT2_5 | STAT2_4 | DOR  | HOVF_Z | HOVF_Y | HOVF_X |
| RW-0    | RW-0    | RW-0    | RW-0    | RW-0 | RW-0   | RW-0   | RW-0   |

NOTE: R=Read access; W=Write access; value following dash (-) = value after reset

| Bit 7-4 | STAT2[7:4] Reserved (Not used)   |  |  |  |  |  |
|---------|--|--|--|--|--|--|
| Bit 3   | DOR Data overrun   |  |  |  |  |  |
|         | DOR bit turns to "1" when data has been skipped in "Continuous measurement" mode. It |  |  |  |  |  |
|         | returns to "0" when the data registers (X, Y, Z) are read                            |  |  |  |  |  |
|         | 0 – Normal   |  |  |  |  |  |
|         | 1 – Data OverRun   |  |  |  |  |  |
| Bit 2   | HOVF_Z Z-axis magnetic sensor overflow   |  |  |  |  |  |
|         | 0 – Normal   |  |  |  |  |  |
|         | 1 – Magnetic Sensor OverFlow occured   |  |  |  |  |  |
| Bit 1   | HOVF_Y Y-axis magnetic sensor overflow   |  |  |  |  |  |
|         | 0 – Normal   |  |  |  |  |  |
|         | 1 – Magnetic Sensor OverFlow occured   |  |  |  |  |  |
| Bit 0   | HOVF_X X-axis magnetic sensor overflow   |  |  |  |  |  |
|         | 0 – Normal   |  |  |  |  |  |
|         | 1 – Magnetic Sensor OverFlow occured   |  |  |  |  |  |

In "Single measurement" mode, "Continuous measurement" mode, the magnetic sensor may overflow even though the measurement data register is not saturated. In this case, measurement data is not correct and HOVF bit turns to "1". When the measurement data register is updated, HOVF bit is updated.

### 6.5.2.4. Addresses 0x08-0x09. T[15:0]

| 0x08 | T[7:0] LSByte of the temperature  |
|------|-----------------------------------|
| 0x09 | T[15:8] MSByte of the temperature |

## 6.5.2.5. Address 0x0A. CID[7:0]

| 0x0A <b>CID[7:0]</b> |
|----------------------|
|----------------------|

### 6.5.2.6. Address 0x0B. DID[7:0]

| 0x0B <b>DID[7</b> | Device ID |
|-------------------|-----------|
|-------------------|-----------|

3D magnetometer Datasheet



## 6.5.2.7. Address 0x0E. CTRL[7:0]

| 7      | 6    | 5    | 4    | 3     | 2     | 1     | 0     |
|--------|------|------|------|-------|-------|-------|-------|
| CTRL_7 | Z_EN | Y_EN | X_EN | MODE3 | MODE2 | MODE1 | MODE0 |
| RW-0   | RW-0 | RW-0 | RW-0 | RW-0  | RW-0  | RW-0  | RW-0  |

NOTE: R=Read access; W=Write access; value following dash (-) = value after reset

| Bit 7   | CTRL[7] Reserved (Not used)             |
|---------|---|
| Bit 6   | Z_EN Enable Z-axis magnetic measurement |
|         | 0 – Disable                             |
|         | 1 – Enable                              |
| Bit 5   | Y_EN Enable Y-axis magnetic measurement |
|         | 0 – Disable                             |
|         | 1 – Enable                              |
| Bit 4   | X_EN Enable X-axis magnetic measurement |
|         | 0 – Disable                             |
|         | 1 – Enable                              |
| Bit 3-0 | MODE[3:0] Application mode              |
|         | 0 – Power-down mode                     |
|         | 1 – Single measurement mode             |
|         | 2 – Continuous measurement mode 10Hz    |
|         | 3 – Continuous measurement mode 20Hz    |
|         | 4 – Continuous measurement mode 50Hz    |
|         | 5 – Continuous measurement mode 100Hz   |
|         | 6 – Continuous measurement mode 125Hz   |
|         | 7 – Not used                            |
|         | 8 – Power-down mode (same as 0)         |
|         | 9 – Single measurement mode (same as 1) |
|         | 10 – Continuous measurement mode 200Hz  |
|         | 11 – Continuous measurement mode 500Hz  |
|         | 12 – Continuous measurement mode 700Hz  |
|         | 13 – Continuous measurement mode 1.0kHz |
|         | 14 – Continuous measurement mode 1.4kHz |
|         | 15 – Power-down mode (same as 0)        |

3D magnetometer Datasheet



## 6.5.2.8. Address 0x0F. CUST\_CTRL2[7:0]

| 7 | C | _ | 1 | 2 | 2 | 1 0 |
|---|---|---|---|---|---|-----|
| / | ס | 5 | 4 | 3 | Z | 1 0 |
|   |   |   |   |   |   |     |

| CUST_CTRL2_<br>7 | CUST_CTRL2_<br>6 | CUST_CTRL2_<br>5 | CUST_CTRL2_<br>4 | CUST_CTRL2_ | RANGE_SEL_<br>2 | RANGE_SEL_<br>1 | RANGE_SEL_<br>0 |
|------------------|------------------|------------------|------------------|-------------|-----------------|-----------------|-----------------|
| P\\/_∩           | P\M/_O           | P\\/_O           | P\\/_O           | P\M/_O      | R\M_O           | P\\/₋O          | P\\/_O          |

| Bit 7-3 | CUST_CTRL2[7-3] Reserved (Not used)     |
|---------|---|
| Bit 2-0 | RANGE_SEL[2:0] Select magnetic range    |
|         | 0 – X and Y axes = 25mT, Z axis = 25mT  |
|         | 1 – X and Y axes = 50mT, Z axis = 25mT  |
|         | 2 – X and Y axes = 25mT, Z axis = 50mT  |
|         | 3 – X and Y axes = 50mT, Z axis = 50mT  |
|         | 4 – X and Y axes = 25mT, Z axis = 100mT |
|         | 5 – X and Y axes = 50mT, Z axis = 100mT |
|         | 6 – X and Y axes = 25mT, Z axis = 200mT |
|         | 7 – X and Y axes = 50mT, Z axis = 200mT |

### 6.5.2.9. Address 0x11. RST[7:0]

| 0x11 | RST[7:0] | Addressed RESET when users sends an I2C_ADDRESSED_RESET command |  |
|------|----------|---|--|
|------|----------|---|--|

### 6.5.2.10. Addresses 0x12-0X13. Not Used



## 6.5.2.11. Address 0x14. OSR\_DIG\_FILT[7:0]

7 6 5 4 3 2 1 0

| OSR_HALL | OSR_TEMP | DIG_FILT_HA<br>LL_XY2 | DIG_FILT_HA<br>LL_XY1 | DIG_FILT_HA<br>LL_XY0 | DIG_FILT_TE<br>MP2 | DIG_FILT_TE<br>MP1 | DIG_FILT_TE<br>MP0 |
|----------|----------|-----------------------|-----------------------|-----------------------|--------------------|--------------------|--------------------|
| RW-0     | RW-0     | RW-0                  | RW-0                  | RW-0                  | RW-0               | RW-0               | RW-0               |

NOTE: R=Read access; W=Write access; value following dash (-) = value after reset

| Bit 7   | OSR_HALL Over sampling ratio setting for the magnetic measurements       |
|---------|--|
|         | 0 - OSR = 32   |
|         | 1 - OSR = 64   |
| Bit 6   | OSR_TEMP Over sampling ratio setting for the temperature measurement     |
|         | 0 - OSR = 32   |
|         | 1 – OSR = 64   |
| Bit 5-3 | DIG_FILT_HALL_XY[2:0] DIG_FILT setting for X and Y magnetic measurements |
|         | 0 – 0.113ms @ OSR_HALL = 0; 0.220ms @ OSR_HALL = 1                       |
|         | 1 – 0.167ms @ OSR_HALL = 0; 0.327ms @ OSR_HALL = 1                       |
|         | 2 – 0.273ms @ OSR_HALL = 0; 0.540ms @ OSR_HALL = 1                       |
|         | 3 – 0.487ms @ OSR_HALL = 0; 0.967ms @ OSR_HALL = 1                       |
|         | 4 – 0.913ms @ OSR_HALL = 0; 1.820ms @ OSR_HALL = 1                       |
|         | 5 – 1.767ms @ OSR_HALL = 0; 3.527ms @ OSR_HALL = 1                       |
|         | 6 – 3.473ms @ OSR_HALL = 0; 6.940ms @ OSR_HALL = 1                       |
|         | 7 – 6.887ms @ OSR_HALL = 0; 13.767ms @ OSR_HALL = 1                      |
| Bit 2-0 | DIG_FILT_TEMP[2:0] DIG_FILT setting for the temperature measurement      |
|         | 0 – 0.113ms @ OSR_TEMP = 0; 0.220ms @ OSR_TEMP = 1                       |
|         | 1 – 0.167ms @ OSR_TEMP = 0; 0.327ms @ OSR_TEMP = 1                       |
|         | 2 – 0.273ms @ OSR_TEMP = 0; 0.540ms @ OSR_TEMP = 1                       |
|         | 3 – 0.487ms @ OSR_TEMP = 0; 0.967ms @ OSR_TEMP = 1                       |
|         | 4 – 0.913ms @ OSR_TEMP = 0; 1.820ms @ OSR_TEMP = 1                       |
|         | 5 – 1.767ms @ OSR_TEMP = 0; 3.527ms @ OSR_TEMP = 1                       |
|         | 6 – 3.473ms @ OSR_TEMP = 0; 6.940ms @ OSR_TEMP = 1                       |
|         | 7 – 6.887ms @ OSR_TEMP = 0; 13.767ms @ OSR_TEMP = 1                      |



## 6.5.2.12. Address 0x15. CUST\_CTRL[7:0]

| 7       | 6       | 5         | 4       | 3          | 2                    | 1                    | 0                    |
|---------|---------|-----------|---------|------------|----------------------|----------------------|----------------------|
| DNC = 1 | DNC = 0 | T_COMP_EN | DNC = 1 | CUST_CTRL3 | DIG_FILT_HA<br>LL_Z2 | DIG_FILT_HA<br>LL_Z1 | DIG_FILT_HA<br>LL_Z0 |
| RW-0    | RW-0    | RW-0      | RW-0    | RW-0       | RW-0                 | RW-0                 | RW-0                 |

NOTE: R=Read access; W=Write access; value following dash (-) = value after reset

| Bit 7   | DNC=1 Value is preloaded from OTP with 0b1. Do not change it.             |
|---------|---|
| Bit 6   | DNC=0 Value is preloaded from OTP with 0b0. Do not change it.             |
| Bit 5   | T_COMP_EN Enable or disabled the temperature measurement and compensation |
|         | 0 – Disabled  |
|         | 1 – Enabled   |
| Bit 4   | DNC=1 Value is preloaded from OTP with 0b1. Do not change it.             |
| Bit 3   | CUST_CTRL3 Reserved (Not used)  |
| Bit 2-0 | DIG_FILT_HALL_Z[2:0] DIG_FILT setting for Z magnetic measurement          |
|         | 0 – 0.113ms @ OSR_HALL = 0; 0.220ms @ OSR_HALL = 1                        |
|         | 1 – 0.167ms @ OSR_HALL = 0; 0.327ms @ OSR_HALL = 1                        |
|         | 2 – 0.273ms @ OSR_HALL = 0; 0.540ms @ OSR_HALL = 1                        |
|         | 3 – 0.487ms @ OSR_HALL = 0; 0.967ms @ OSR_HALL = 1                        |
|         | 4 – 0.913ms @ OSR_HALL = 0; 1.820ms @ OSR_HALL = 1                        |
|         | 5 – 1.767ms @ OSR_HALL = 0; 3.527ms @ OSR_HALL = 1                        |
|         | 6 – 3.473ms @ OSR_HALL = 0; 6.940ms @ OSR_HALL = 1                        |
|         | 7 – 6.887ms @ OSR_HALL = 0; 13.767ms @ OSR_HALL = 1                       |



# 6.6. Flowchart

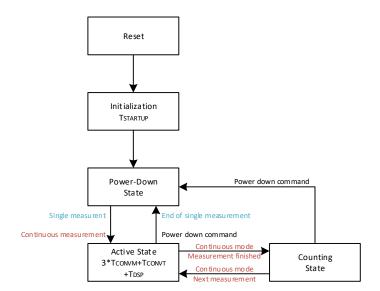


Figure 17: Sequence flowchart



# 6.7. Noise Performance Graphs

## 6.7.1. Without temperature compensation

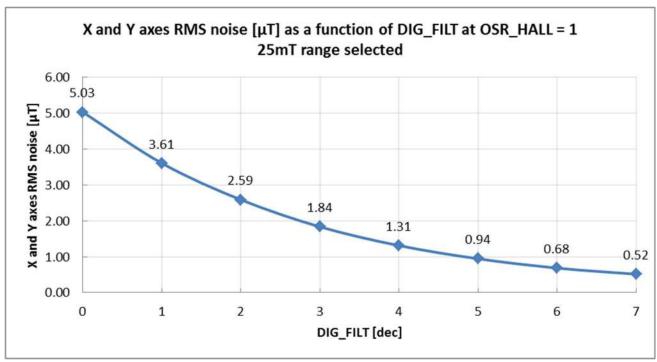


Figure 18: XY axis RMS noise (typ) without temperature compensation and 25mT range selected

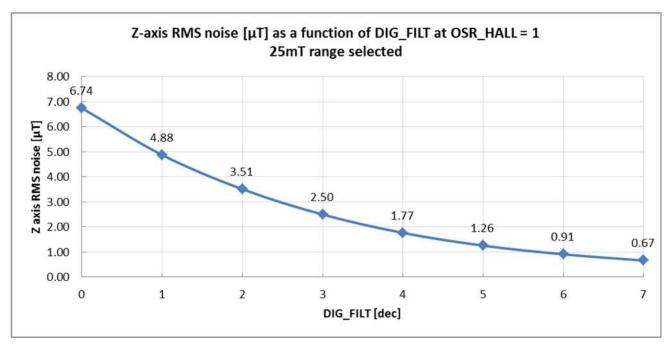


Figure 19: Z axis RMS noise (typ) without temperature compensation and 25mT range selected



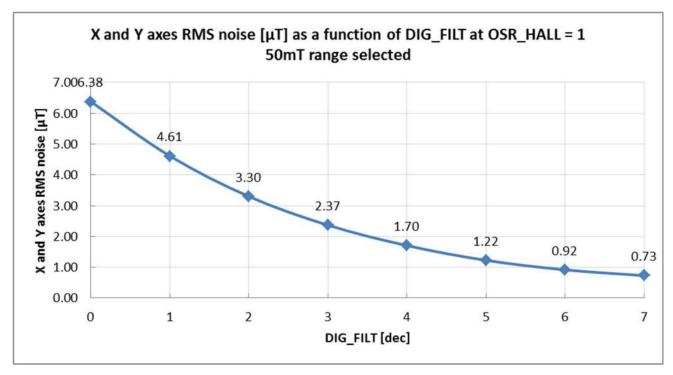


Figure 20: XY axis RMS noise (typ) without temperature compensation and 50mT range selected

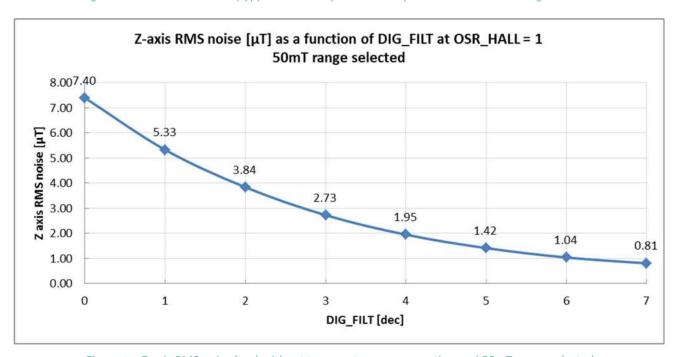


Figure 21: Z axis RMS noise (typ) without temperature compensation and 50mT range selected



## 6.7.2. With temperature compensation

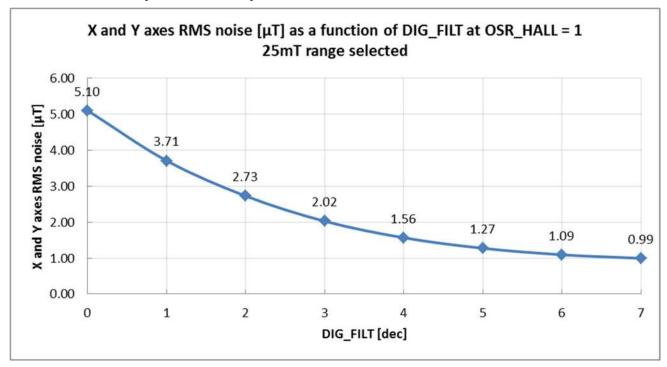


Figure 22: XY axis RMS noise (typ) with temperature compensation and 25mT range selected

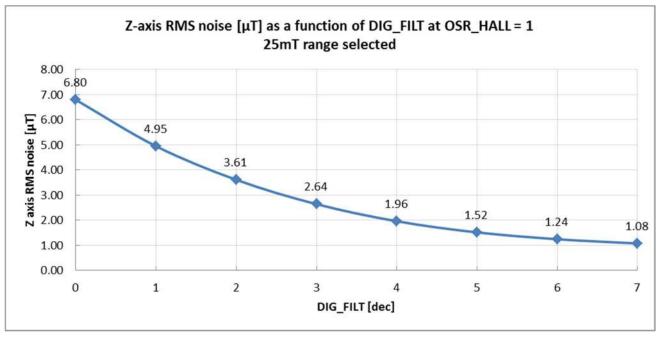


Figure 23: Z axis RMS noise (typ) with temperature compensation and 25mT range selected



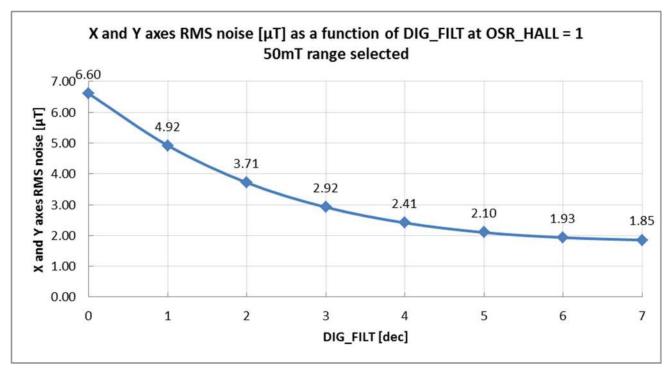


Figure 24: XY axis RMS noise (typ) with temperature compensation and 50mT range selected

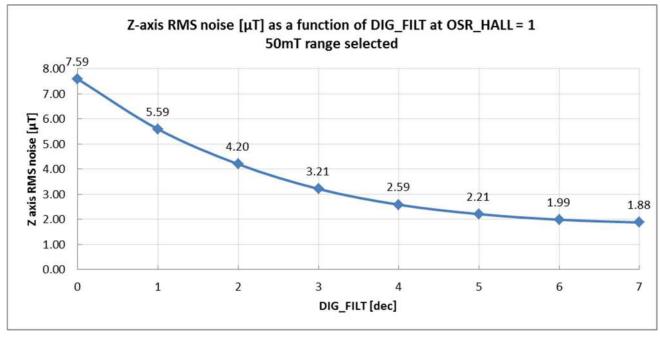


Figure 25: Z axis RMS noise (typ) with temperature compensation and 50mT range selected

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## 6.8. Temperature Compensation

The MLX90397 has a built-in temperature compensation, which is done by a piecewise linear approximation of the temperature coefficient of the Hall plates. A reference temperature is chosen (TREF=35°C), where the result at any temperature higher than TREF is adjusted by a gain SENT\_TC\_HT and if the temperature is lower than TREF - by SENS\_TC\_LT. These two coefficients are calibrated at Melexis and are lumped into the parameter name SENS\_TC in the equation below.

$$\mathsf{XYZ}_{18\_0} = \mathsf{XYZ\_RAW}_{18\_0} \cdot \left[ 1 + \frac{\mathsf{SENS\_TC}_{11\_0} \cdot \left( \mathsf{TEMP}_{15\_0} - \mathsf{TREF}_{15\_0} \right)}{2^{\mathsf{SENS\_TC}\_N_{3\_0} + 18}} \right]$$

SENS\_TC\_N is a scaling factor needed for the fixed-point calculations. It is determined and written at Melexis during the production test.

In case the temperature compensation is not needed, bit 5 in T\_EN\_DIG\_FILT\_Z register is set to 0. This also disables the temperature measurement and the term in the square brackets of the formula above is equal to 1.

The operation is executed on the 19 bits raw magnetic data which is consequently truncated to 16 bit and loaded into the results registers.



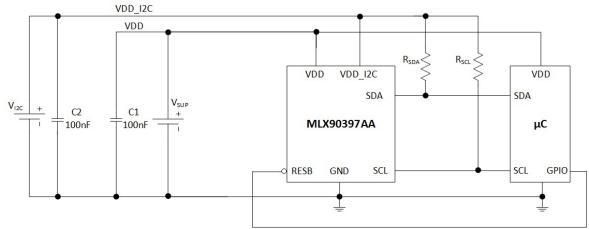
# 7. Application information

# **Recommended application diagram**

The MLX90397 package features an exposed pad. Considering the low self-heating of the component, no recommendation is given whether or not to connect this pad to ground.

MLX90397 can be reset by pulling down the RESB pin to GND with:

An open-drain output of a microcontroller having a pull-down resistance of less than 5kΩ:



• A capacitor connected between RESB and GND pins (for start-up, without microcontroller). The capacitor value can be calculated with:  $C_{RESB} \geq 500 \mu A \cdot \frac{\Delta t}{\Delta V_{DD}}$ , with  $\frac{\Delta V_{DD}}{\Delta t}$  equal to the voltage supply ramp rate:

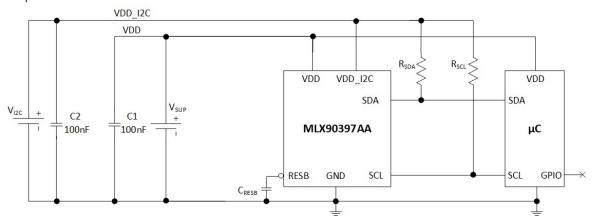


Figure 26: Recommended application diagram

Note: R<sub>SDA</sub> and R<sub>SCL</sub> are part of the bus specifications. Please refer to it.



#### **Package and Manufacturability information** 8.

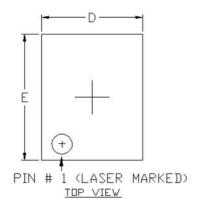
# 8.1. ESD precaution

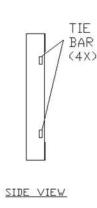
Electronic semiconductor products are sensitive to Electro Static Discharge (ESD). Always observe Electro Static Discharge control procedures whenever handling semiconductor products.

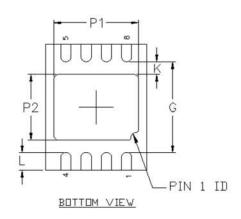
# 8.2. Package information – UTDFN8

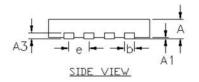
### 8.2.1. Dimensions

UTDFN 2x2.5mm









### NOTE:

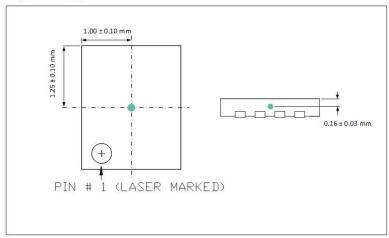
- ALL DIMENSIONS IN MILLIMETERS (mm).
   EXPOSED TIE BAR SHOULD BE KEPT FREE FROM SOLDER.

| SYMBOL | MINIMUM  | MAXIMUM |  |
|--------|----------|---------|--|
| Α      | 0.31     | 0.40    |  |
| A1     | 0.00     | 0.05    |  |
| A3     | 0.12 REF |         |  |
| D      | 1.90     | 2.10    |  |
| E      | 2.40     | 2.60    |  |
| P1     | 1.45     | 1.70    |  |
| P2     | 1.25     | 1.35    |  |
| G      | 1.75     | 1.85    |  |
| L      | 0.25     | 0.45    |  |
| K      | 0.20     |         |  |
| ь      | 0.16     | 0.24    |  |
| е      | 0.40 BSC |         |  |



## 8.2.2. Sensing element placement

#### Magnetic sweet spot



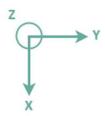


Figure 27: Field convention (Top view of the package with pin 1 at the bottom left)

# 8.2.3. Top Marking



Line 1

Line 2

Line 3



Line 1: 97AB, with B=0 for -000 and B=1 for -001 Line 2: WWY Assembly date

> WW = calendar week# Y = last digit of the year

Line3: **dot** = pin 1 position

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## 8.3. Standard information on soldering processes

### 8.3.1. Storage and handling of plastic encapsulated ICs

Plastic encapsulated ICs shall be stored and handled according to their MSL categorization level (specified in the packing label) as per J-STD-033.

Electronic semiconductor products are sensitive to Electro Static Discharge (ESD). The component assembly shall be handled in EPA (Electrostatic Protected Area) as per ANSI S20.20

For more information refer to Melexis *Guidelines for storage and handling of plastic encapsulated ICs* (13)

## 8.3.2. Assembly of encapsulated ICs

For Surface Mounted Devices (SMD, as defined according to JEDEC norms), the only applicable soldering method is reflow.

For Through Hole Devices (THD), the applicable soldering methods are reflow, wave, selective wave and robot point-to-point. THD lead pre-forming (cutting and/or bending) is applicable under strict compliance with Melexis *Guidelines for lead forming of SIP Hall Sensors* <sup>(13)</sup>.

Melexis products soldering on PCB should be conducted according to the requirements of IPC/JEDEC and J-STD-001. Solder quality acceptance should follow the requirements of IPC-A-610.

For PCB-less assembly refer to the relevant application notes (13) or contact Melexis.

Electrical resistance welding or laser welding can be applied to Melexis products in THD and specific PCB-less packages following the *Guidelines for welding of PCB-less devices*<sup>(13)</sup>.

Environmental protection of customer assembly with Melexis products for harsh media application, is applicable by means of coating, potting or overmolding considering restrictions listed in the relevant application notes (13)

For other specific process, contact Melexis via www.melexis.com/technical-inquiry

### 8.3.3. Environment and sustainability

Melexis is contributing to global environmental conservation by promoting non-hazardous solutions. For more information on our environmental policy and declarations (RoHS, REACH...) visit www.melexis.com/environmental-forms-and-declarations

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<sup>13</sup> www.melexis.com/ic-handling-and-assembly

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# 11. Revision History

| Revision | Date          | Change history   |
|----------|---------------|--|
| 001      | 14-March-2022 | First datasheet  |
| 002      | 23-Dec-2022   | Cosmetic changes Note on exposed pad Idle mode -> Power-Down mode Update Application diagram (removal of capacitor), added description for RESB Order code added -001, including package marking update Remove line regarding RESB resistor from table electrical specifications (moved to description for RESB) Correction formula T_CONV |
|          |               |  |

Table 18: Revisions

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